

<b>Notice of References Cited</b>	Application/Control No. 10/568,284		Applicant(s)/Patent Under Reexamination ONODA ET AL.	
	Examiner Thuy N. Pardo		Art Unit 2627	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,103,663	09-2006	Inoue et al.	709/225
*	B	US-2004/0186853	09-2004	Yamamoto et al.	707/104.1
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

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	N					
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#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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